

# SLF80R240GT/SLB80R240GT

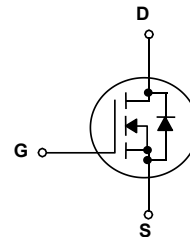
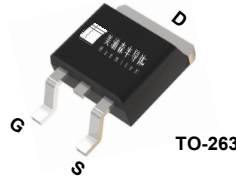
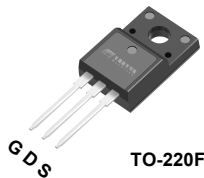
## 800V N-Channel Multi-EPI Super-JMOSFET

### General Description

This Power MOSFET is produced using Msemitek's advanced Superjunction MOSFET technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies.

### Features

- 850V@ $T_J=150^{\circ}\text{C}$
- 18A,800V,  $R_{DS(on)}=205\text{m}\Omega@V_{GS}=10\text{V}$
- Low gate charge(typ.  $Q_g=46\text{nC}$ )
- High ruggedness
- Ultra fast switching
- 100% avalanche tested
- Improved dv/dt capability



### Absolute Maximum Ratings $T_C = 25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	SLF80R240GT	SLB80R240GT	Units
$V_{DS}$	Drain-Source Voltage	800		V
$I_D$	Drain Current * - Continuous ( $T_C = 25^{\circ}\text{C}$ ) - Continuous ( $T_C = 100^{\circ}\text{C}$ )	18		A
		12		A
$I_{DM}$	Drain Current * - Pulsed (Note 1)	54		A
$V_{GS}$	Gate-Source Voltage	$\pm 30$		V
$E_{AS}$	Single Pulsed Avalanche Energy (Note 2)	690		mJ
$P_D$	Power Dissipation ( $T_C = 25^{\circ}\text{C}$ ) - Derate above $25^{\circ}\text{C}$	83	208	W
		0.67	1.67	W/ $^{\circ}\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150		$^{\circ}\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	260		$^{\circ}\text{C}$

\* Drain current limited by maximum junction temperature.

### Thermal Characteristics

Symbol	Parameter	SLF80R240GT	SLB80R240GT	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.5	0.55	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	$^{\circ}\text{C}/\text{W}$

## Package Marking

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLF80R240GT	SLF80R240GT	TO-220F	Tube	1000	5000
SLB80R240GT	SLB80R240GT	TO-263	Tape	800	4000

## Electrical Characteristics

$T_C = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	800	--	--	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$	--	--	1	$\mu\text{A}$
$I_{GSSF}$	Gate-Body Leakage Current, Forward	$V_{GS} = 30\text{ V}, V_{DS} = 0\text{ V}$	--	--	100	nA
$I_{GSSR}$	Gate-Body Leakage Current, Reverse	$V_{GS} = -30\text{ V}, V_{DS} = 0\text{ V}$	-100	--	--	nA

### On Characteristics

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	2.5	--	4.5	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}, I_D = 9\text{ A}$	--	205	240	m $\Omega$

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V},$ $f = 100\text{ KHz}$	--	2030	--	pF
$C_{oss}$	Output Capacitance		--	83	--	pF
$C_{rss}$	Reverse Transfer Capacitance		--	1.8	--	pF

### Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time	$V_{DS} = 400\text{ V}, I_D = 9\text{ A},$ $R_G = 4.7\ \Omega, V_{GS} = 10\text{ V}$ (Note3)	--	20	--	ns
$t_r$	Turn-On Rise Time		--	39	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	56	--	ns
$t_f$	Turn-Off Fall Time		--	19	--	ns
$Q_g$	Total Gate Charge	$V_{DS} = 400\text{ V}, I_D = 9\text{ A},$ $V_{GS} = 10\text{ V}$ (Note3)	--	46	--	nC
$Q_{gs}$	Gate-Source Charge		--	13	--	nC
$Q_{gd}$	Gate-Drain Charge		--	21	--	nC
$R_G$	Gate Resistance	$f = 1\text{ MHz}$	--	2.1	--	$\Omega$

### Drain-Source Diode Characteristics and Maximum Ratings

$I_S$	Maximum Continuous Drain-Source Diode Forward Current	--	--	18	A	
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current	--	--	54	A	
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 18\text{ A}$	--	--	1.4	V
$t_{rr}$	Reverse Recovery Time	$V_{DS} = 400\text{ V}, I_S = 9\text{ A},$ $di_F / dt = 130\text{ A}/\mu\text{s}$	--	280	--	ns
$Q_{rr}$	Reverse Recovery Charge		--	4.8	--	$\mu\text{C}$

#### Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
2. EAS condition:  $T_J = 25^\circ\text{C}, V_{DD} = 50\text{ V}, V_G = 10\text{ V}, L = 10\text{ mH}$ ,
3. Pulse Test: Pulse Width  $\leq 300\ \mu\text{s}$ , Duty Cycle  $\leq 0.5\%$

### Typical Characteristics

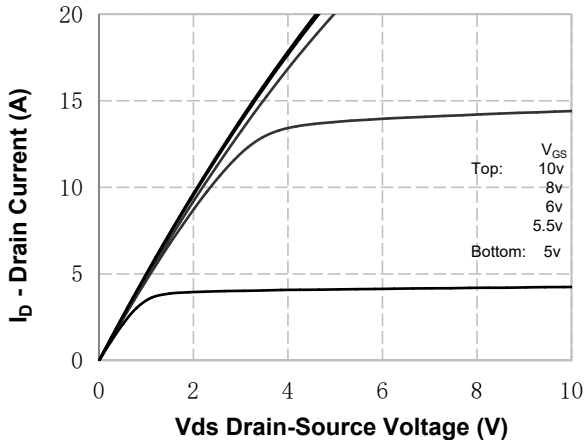


Figure 1. On-Region Characteristics

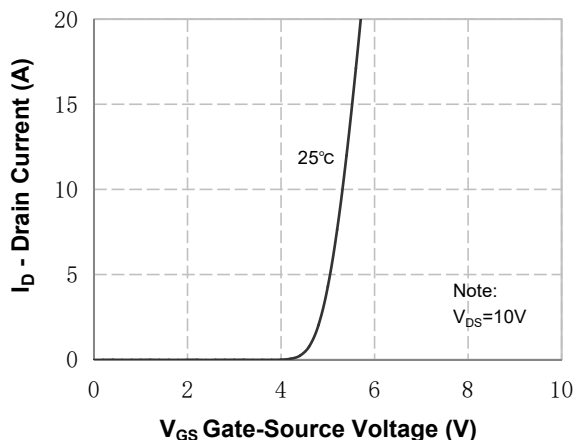


Figure 2. Transfer Characteristics

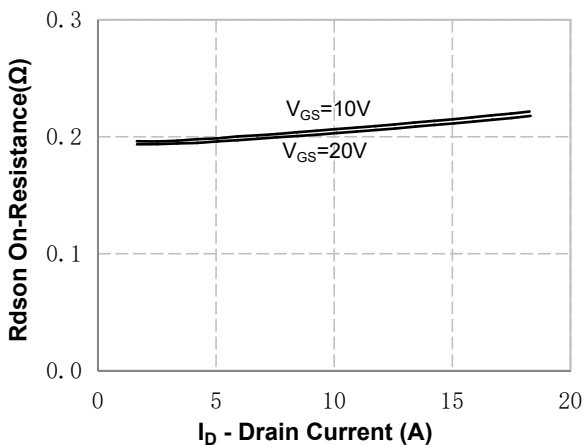


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

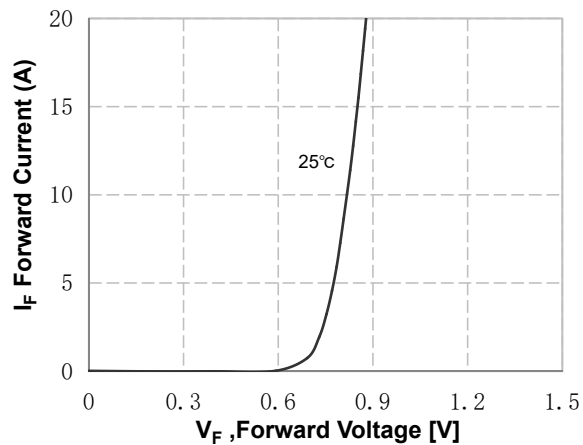


Figure 4. Body Diode Forward Voltage Variation with Source Current

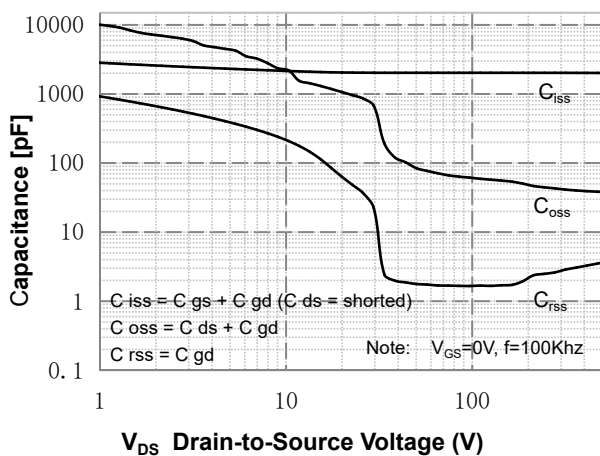


Figure 5. Capacitance Characteristics

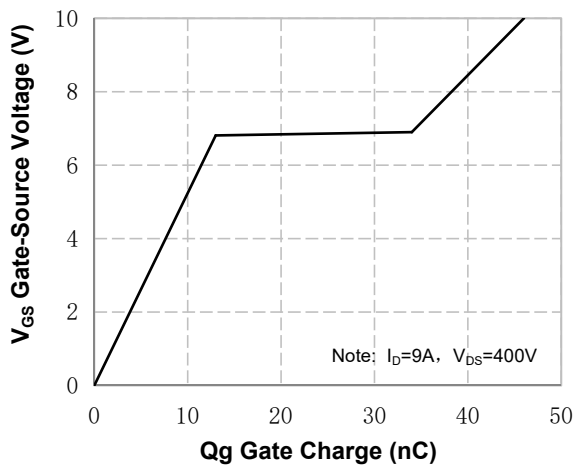


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

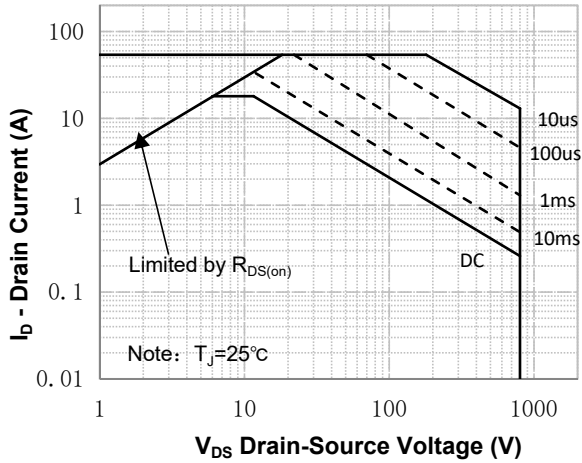


Figure 7. Maximum Safe Operating Area

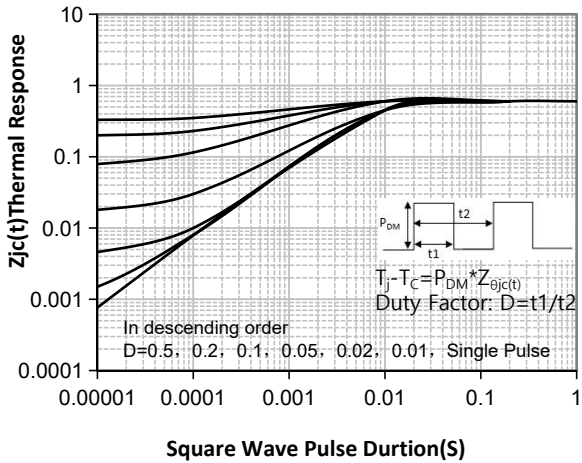


Figure 9. Transient Thermal Response Curve (for SLB80R240GT)

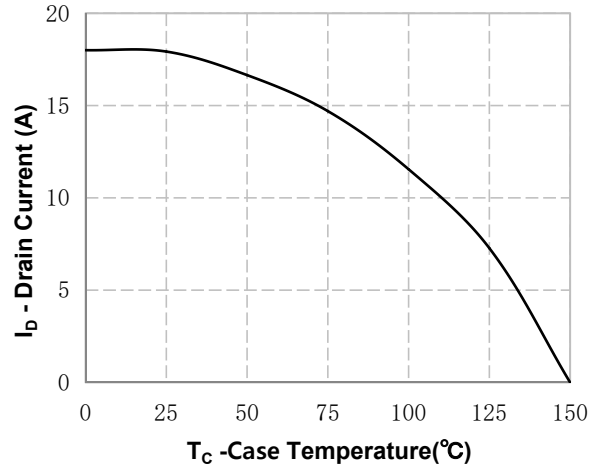
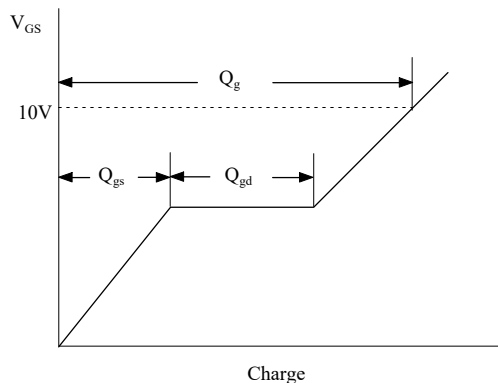
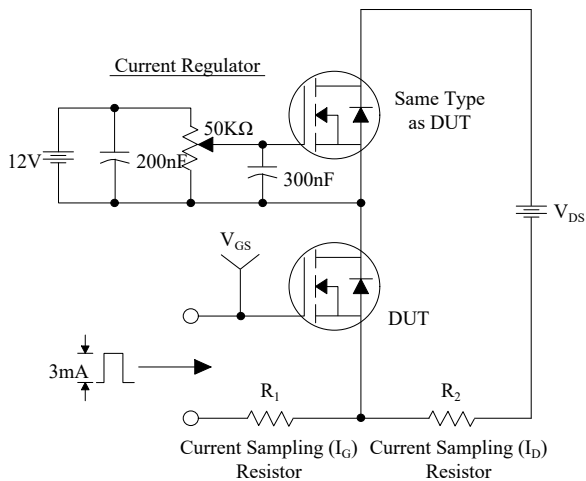
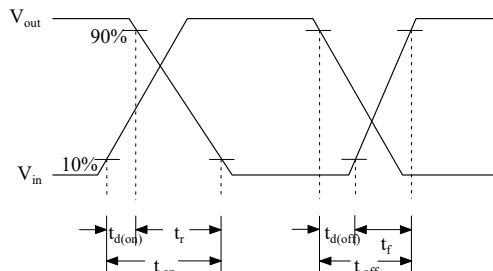
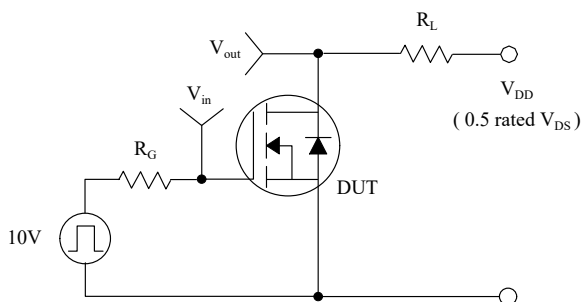


Figure 8. Maximum Drain Current vs Case Temperature

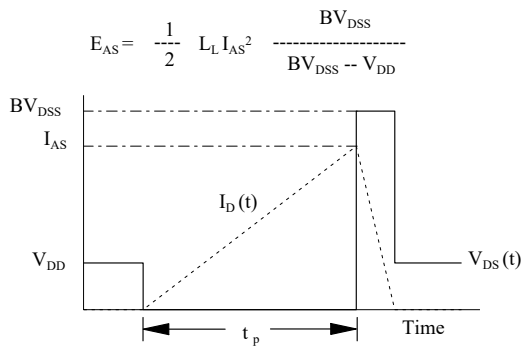
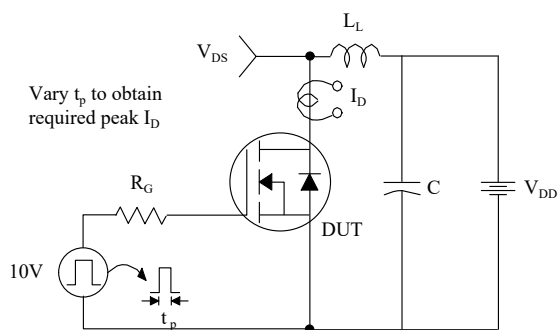
### Gate Charge Test Circuit & Waveform



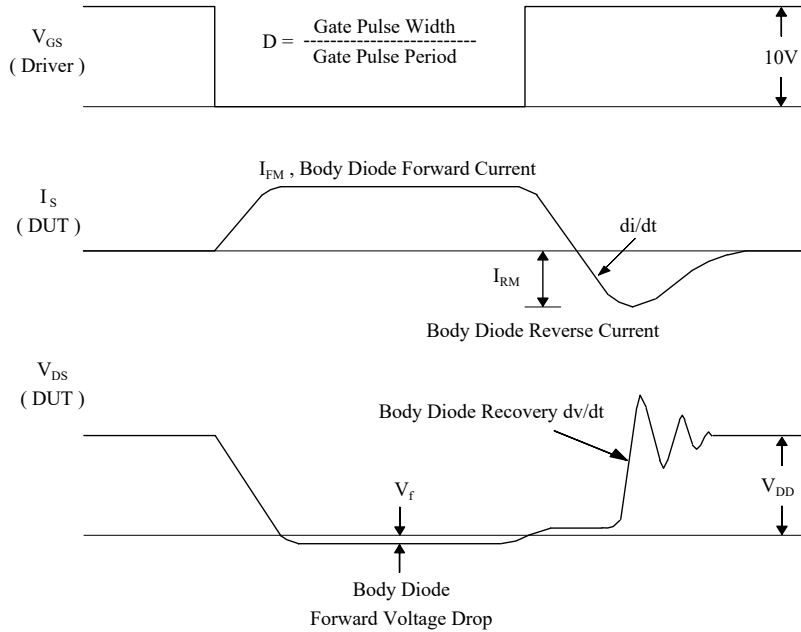
### Resistive Switching Test Circuit & Waveforms



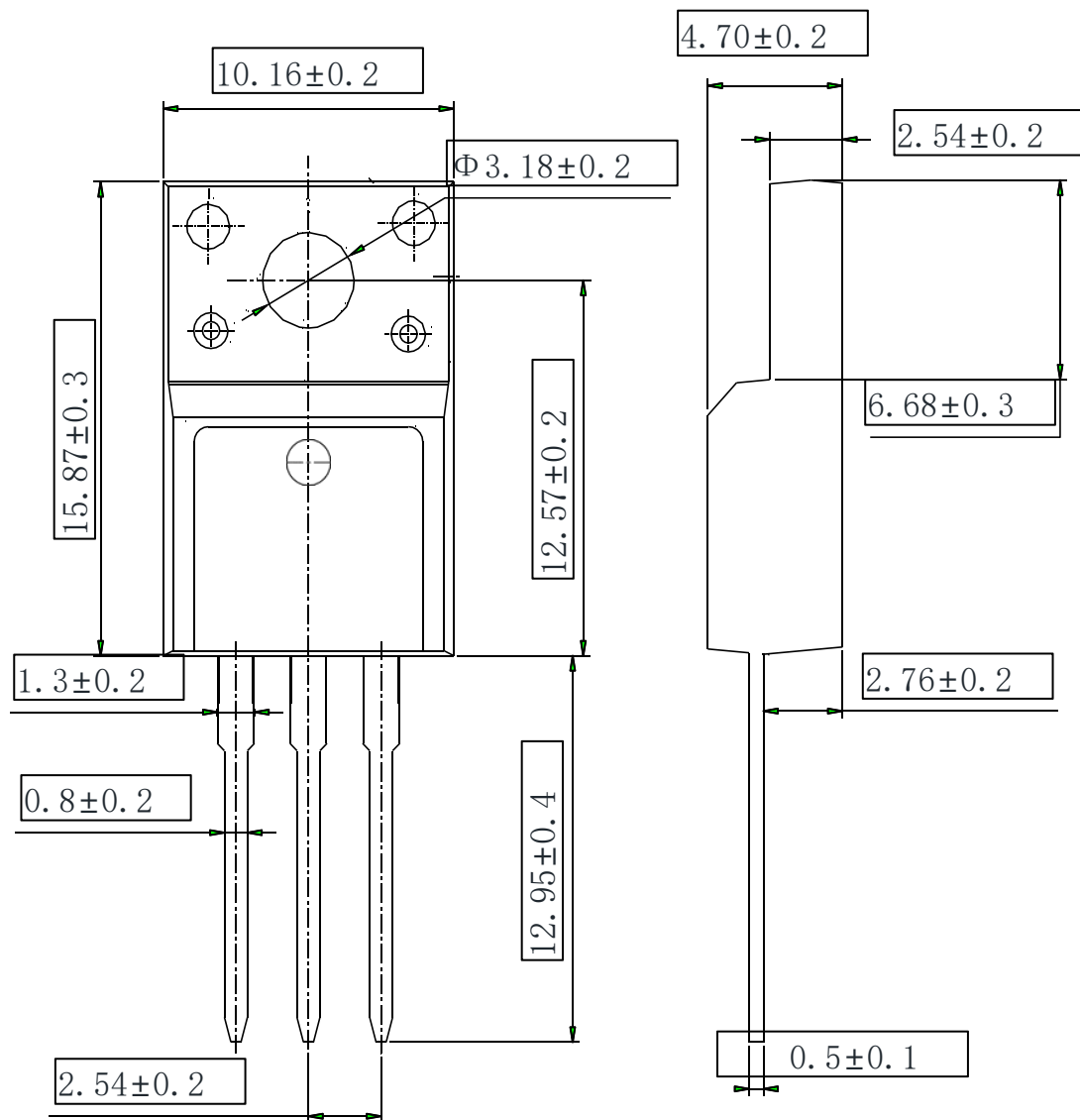
### Unclamped Inductive Switching Test Circuit & Waveforms



## Peak Diode Recovery dv/dt Test Circuit & Waveforms



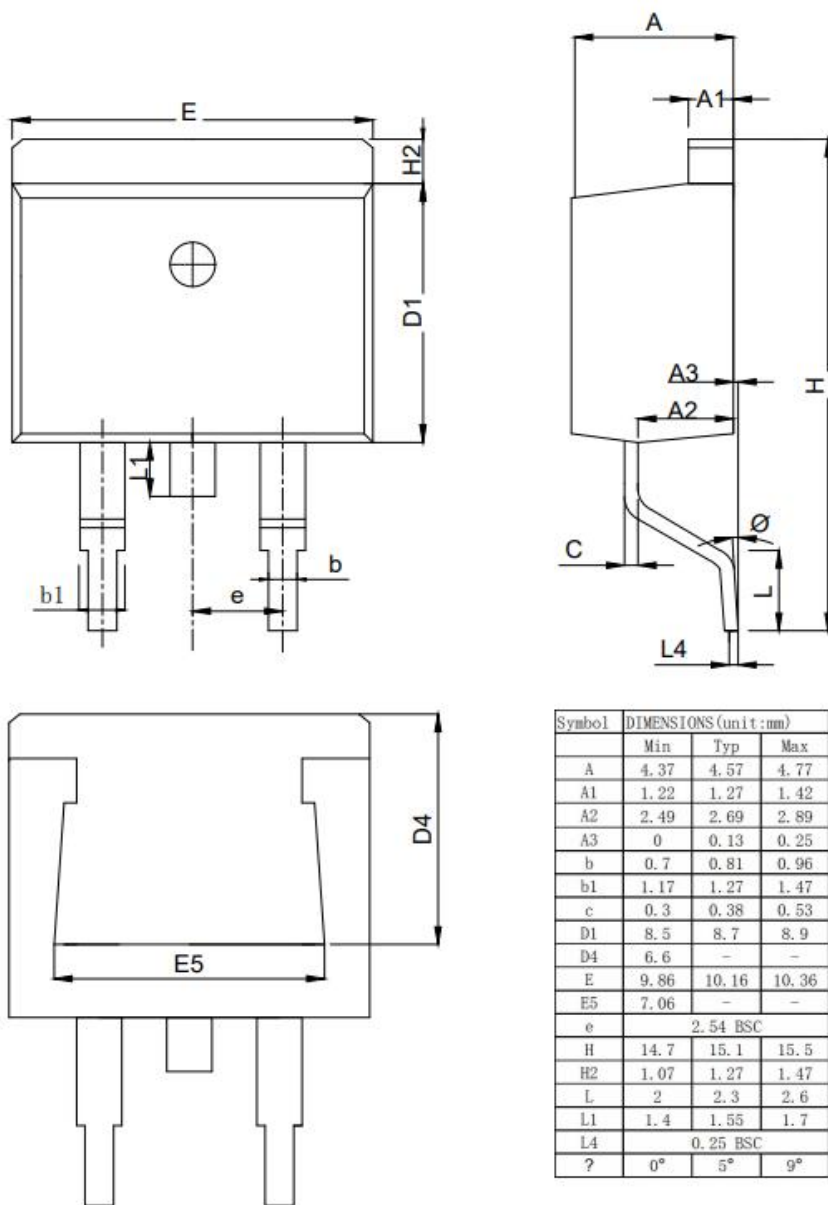
## TO-220F OUTLINE



## NOTE:

- 1The plastic package is not marked as smooth surface  $Ra=0.1$ ; Subglossy surface  $Ra=0.8$
2. Undeclared tolerance  $\pm 0.15$ , Unmarked fillet  $R_{max}=0.25$

## TO-263 OUTLINE



## NOTE:

- 1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8
- 2.Undeclared tolerance  $\pm 0.25$ ,Unmarked filletRmax=0.25



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